

# Coronagraph Starlight Suppression Model Validation

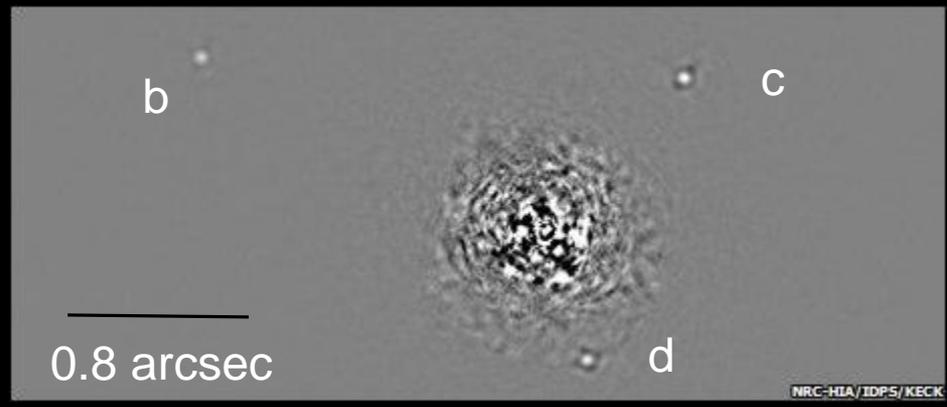
Stuart Shaklan, Erkin Sidick, Eric Cady, Brian Kern, Kunjithapatham  
Balasubramanian, and John Krist

Mirror Tech Days 2015  
Annapolis, MD

11/12/ 2015

# Direct Imaging from the Ground

HR 8799



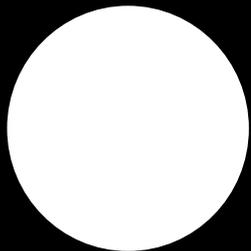
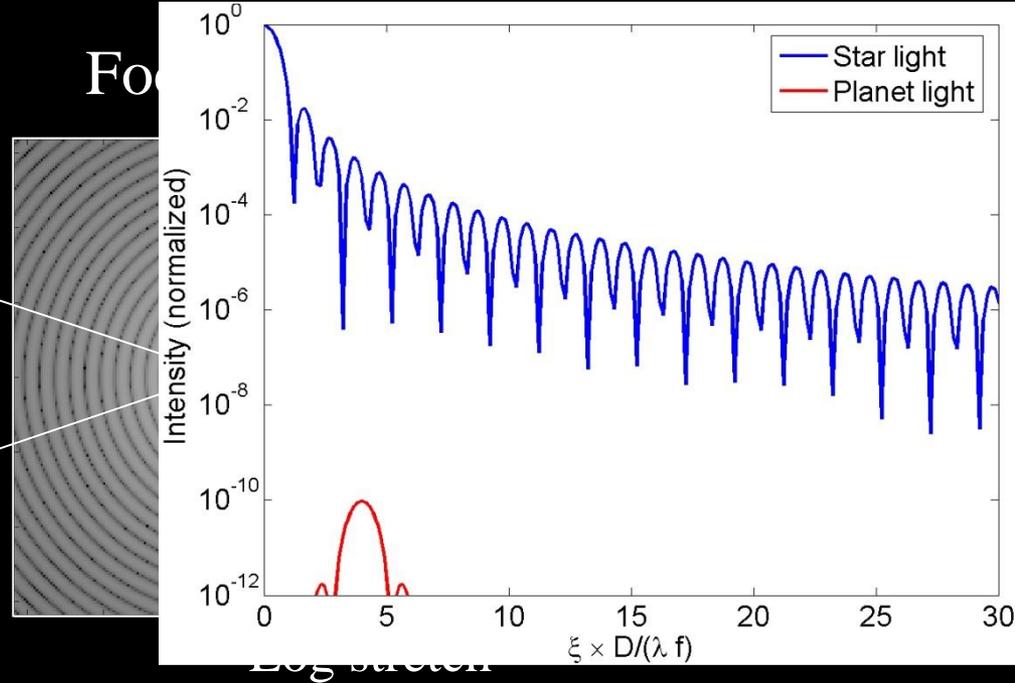
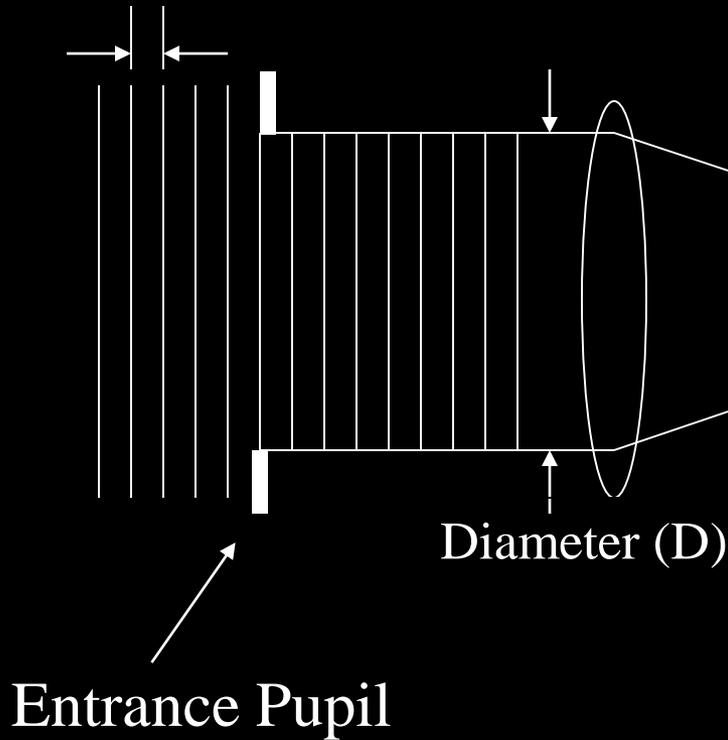
Keck adaptive optics image of 6<sup>th</sup> magnitude HR 8799 and its 3 massive Jovian planets.

Contrast of planets about 10,000:1

# Diffraction

Unfortunately, the planet would be

Wavelength ( $\lambda$ )



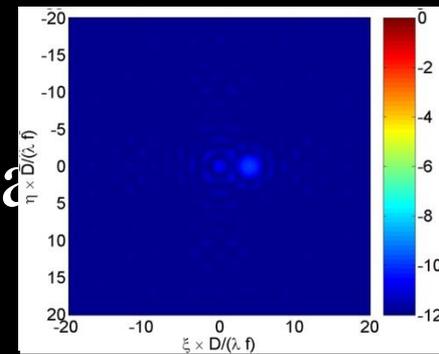
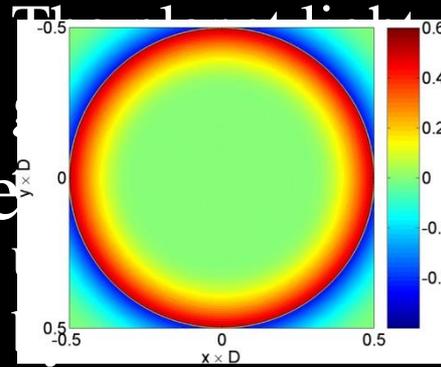
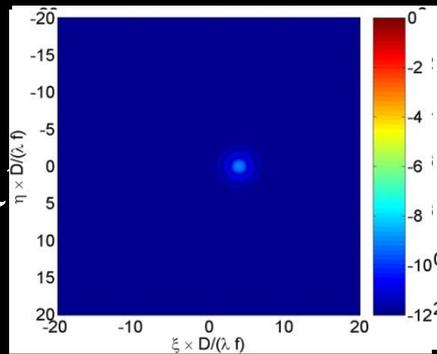
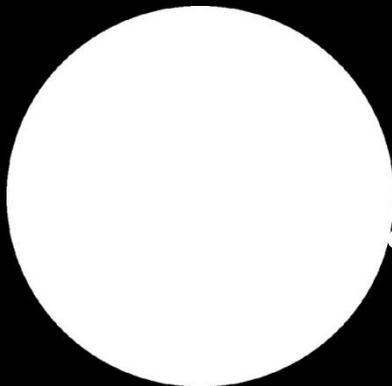
# The Lyot Coronagraph

Entrance pupil

Occulter

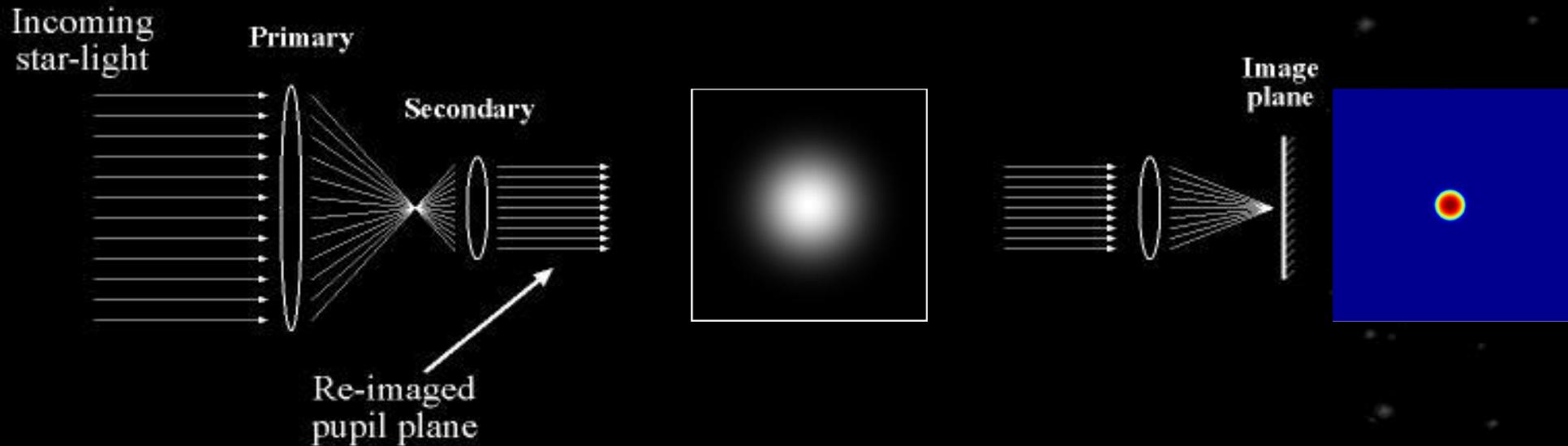
Lyot stop

Image plane



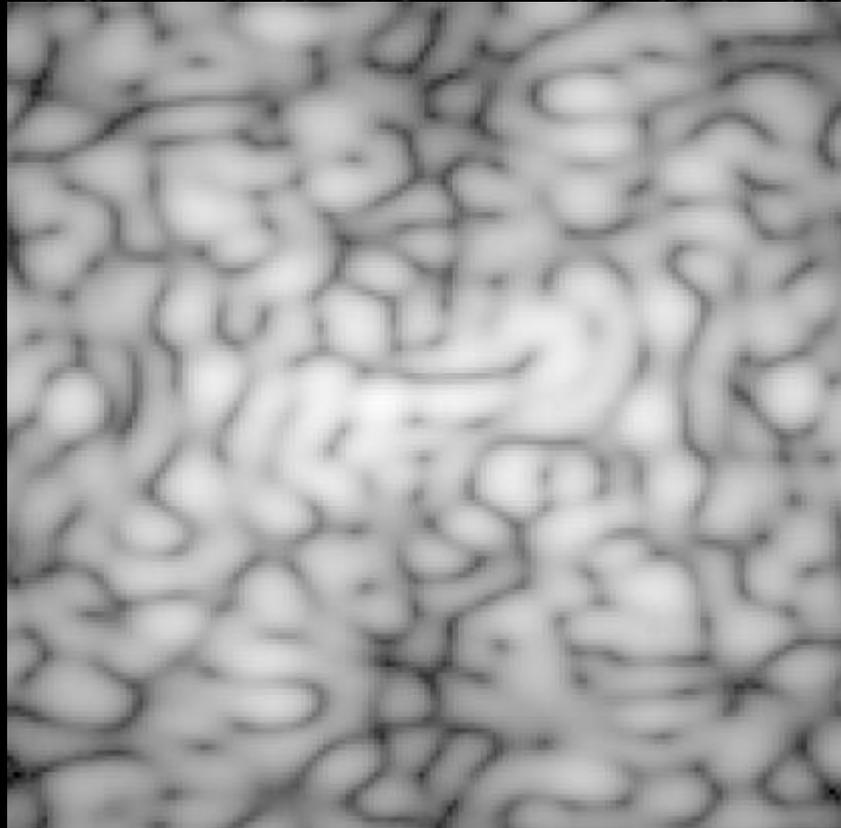
Stuart Shaklan

# The Apodized Pupil Coronagraph



# Digging Deeper

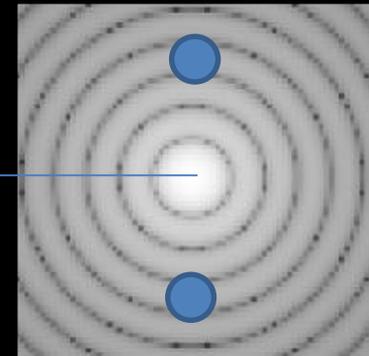
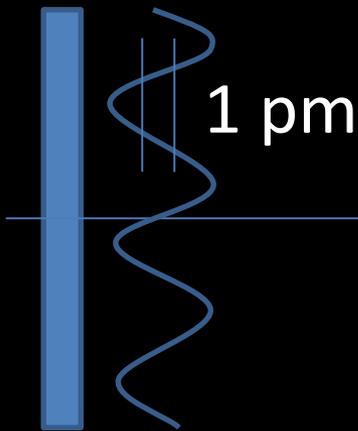
What's left over  
After removing diffraction



# Deformable Mirror and Wavefront Control

Sine wave, 3 cycles/aperture

Speckles at  $3 \lambda/D$



*Amplitude*

*Relative intensity (Contrast)*

$\theta$  Radians rms

Marechal Approximation  $C = \theta^2 / 2$

1 picometer

$$\frac{1}{2} \left( \frac{2\pi * 1 \text{ pm}}{1 \mu\text{m}} \right)^2 = 2 * 10^{-11}$$



# How Challenging is Direct Detection of Terrestrial Planets in Visible Light?

Imagine looking for a bump  
1/100 the thickness of a human  
hair...

...on the slopes of Mt. Everest!!



90 microns / 100 =  $9e-7$  m



9000 m =  $9e3$  m

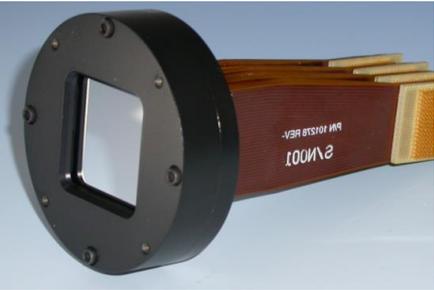
That's a ratio of  $1e10$ , same as Earth to Sun contrast!!

# Model Validation Tests

*From Milestone #3A Final Report (Draft)*

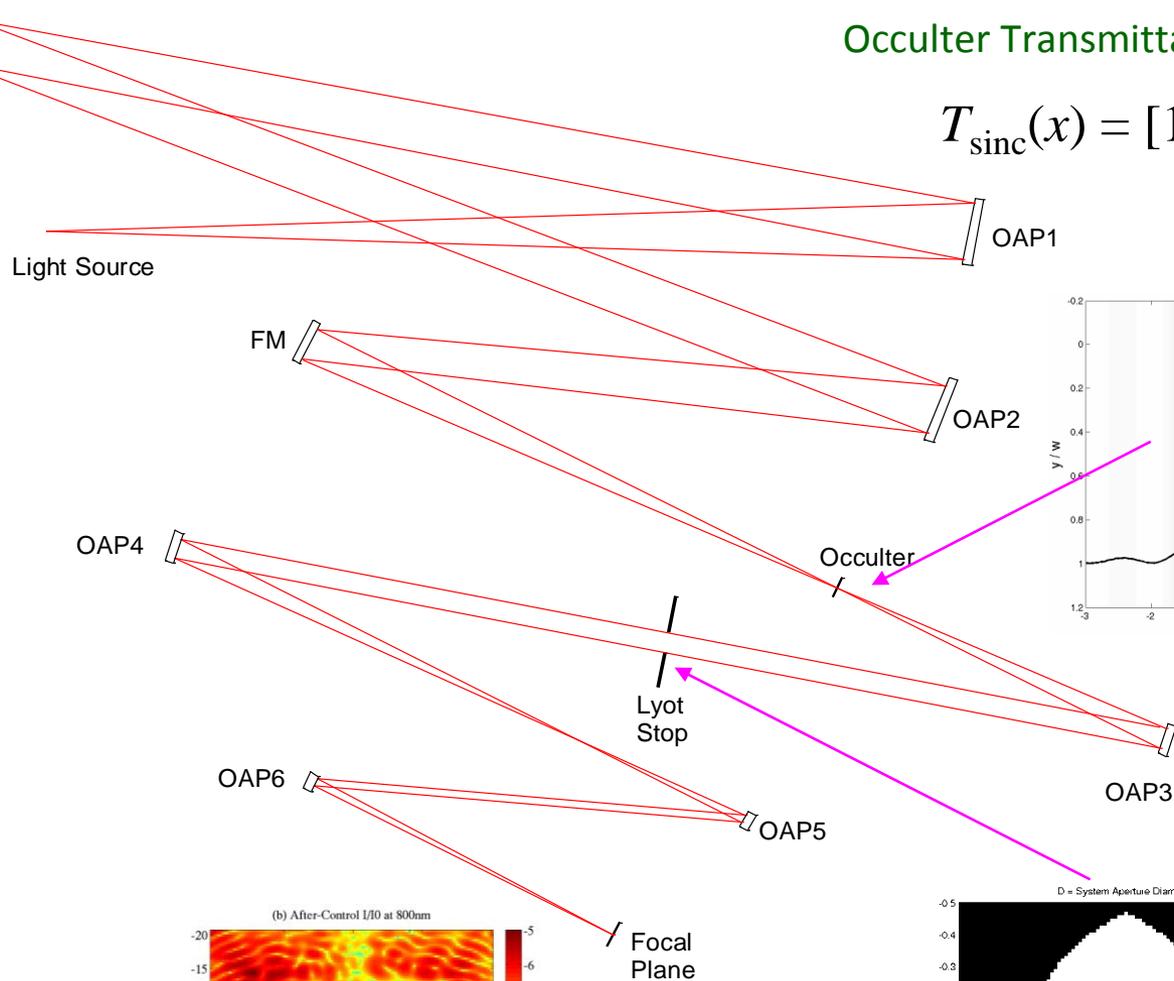
Open Loop Test (DM Static)	Purpose
Source Lateral Focus and Pos'n	Sensitivity to image motion and focus
Closed Loop Tests (Wavefront Control)	Purpose
Occulter Mask Defect	Effect of contamination
Dark Hole Size	Contrast floor vs. Dark Hole size
Control Bands	Contrast vs. $\lambda$ vs. controlled bands
Pegged Actuators	Sensitivity to failures
Incoherent light estimation	Distinguish planet from instr. scatter

# High Contrast Imaging Testbed Optical System



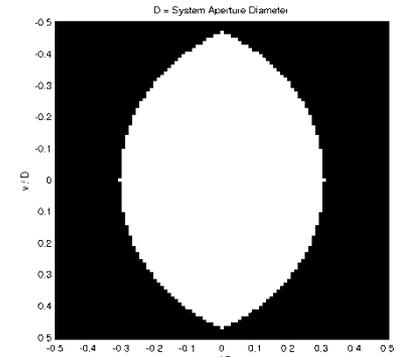
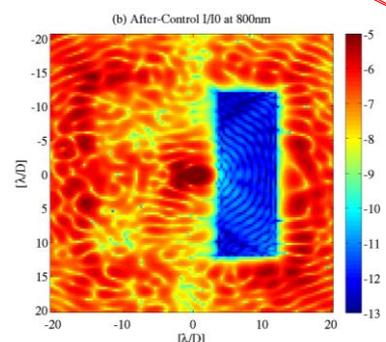
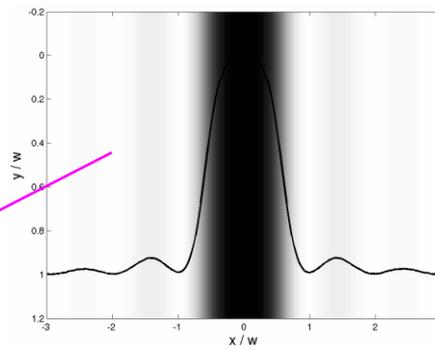
32x32 Actuator Deformable-Mirror

Currently HCIT uses  
 48x48 actuators of a  
 64x64 actuator DM



Occulter Transmittance:

$$T_{\text{sinc}}(x) = [1 - \text{sinc}^2(x/w)]^2$$



# Occulter OD & Phase Profiles, and Their Dispersion

Use a Ni occulter deposited on a fused quartz substrate

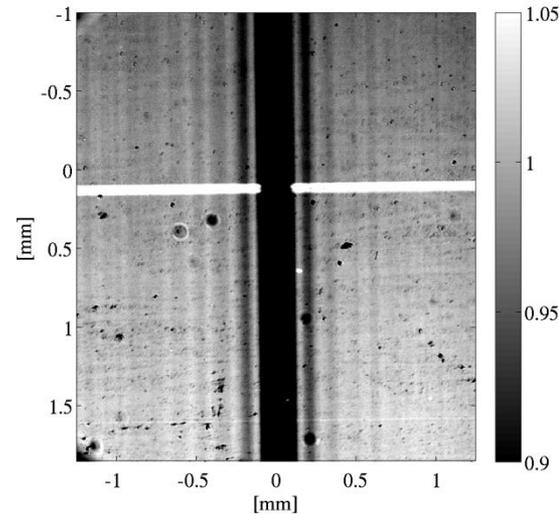
$$T_{\text{sinc}}(x) = [1 - \text{sinc}^2(x/w)]^2$$

$$w = 142\mu\text{m}$$

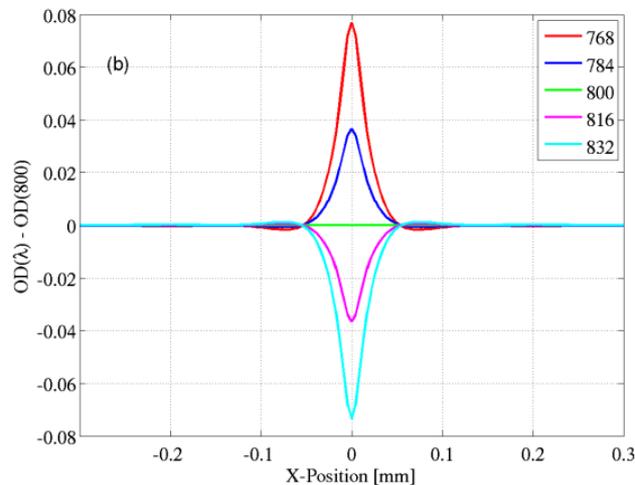
Truncation & Smoothing →

$$T_{\text{rel}}(x)$$

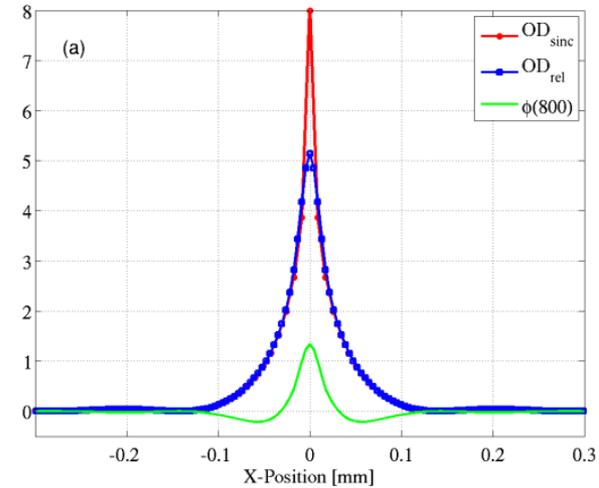
Measured Occulter Transmittance



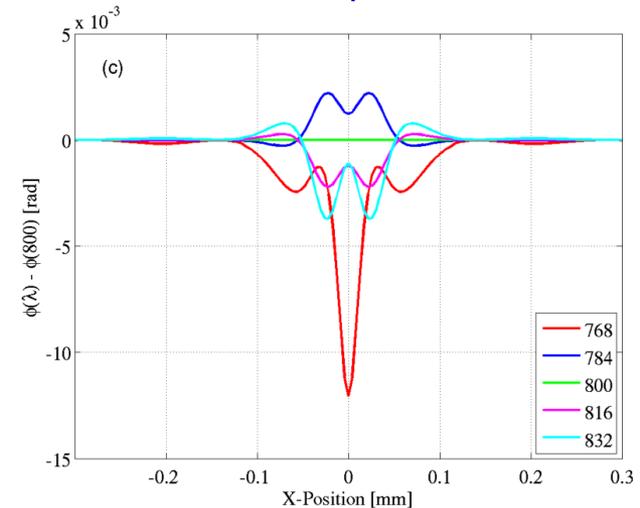
OD Dispersion



OD & Phase Profile



Phase Dispersion

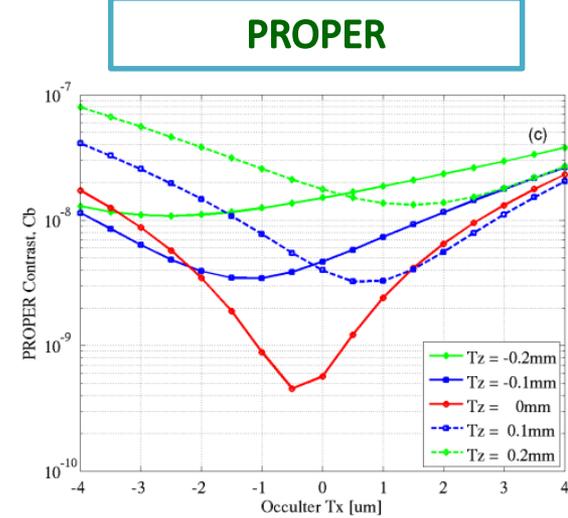
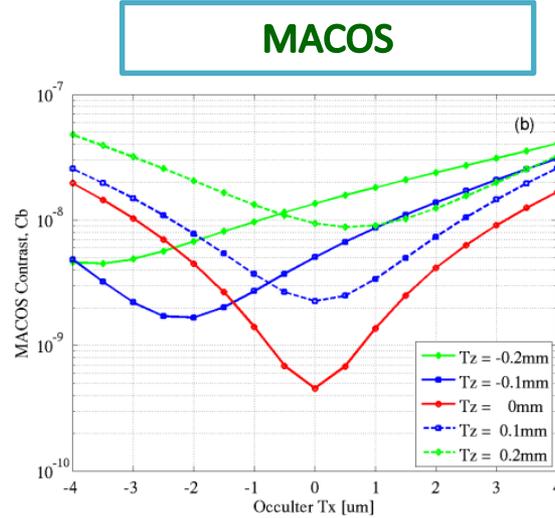
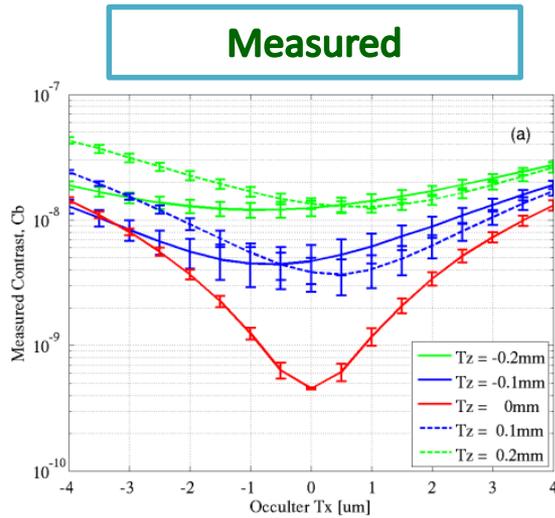


Occulter phase is in radians

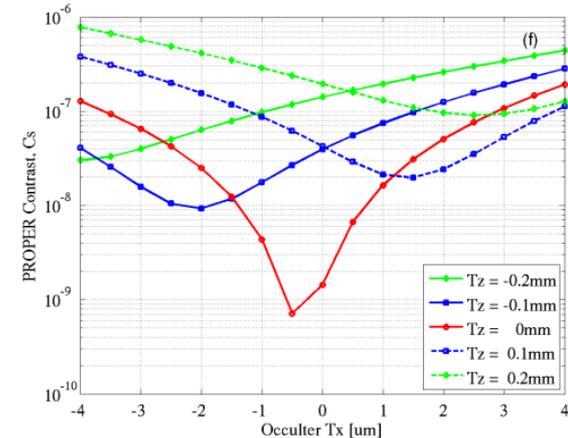
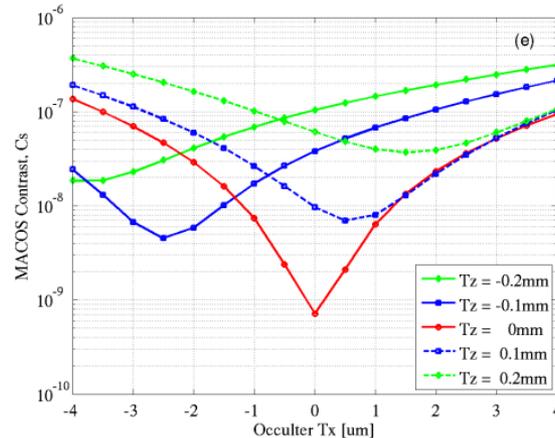
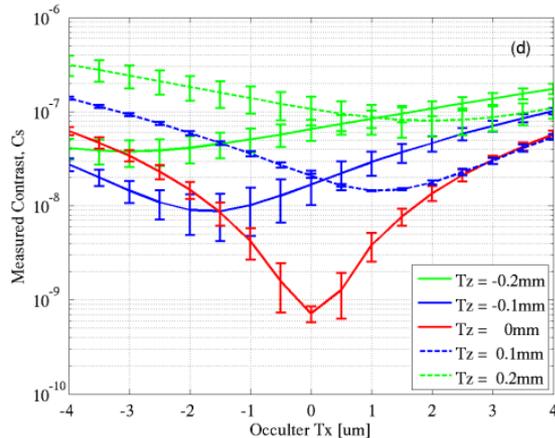
# Translation vs. Focus: Measurement versus Simulations

- Simulation does not account for any experimental floor due to incoherent scattered light, so yields much better contrast floor
- Adjusted  $C_b$  and  $C_s$  values to match with measured ones at  $T_x = T_z = 0$  point
- Measured & simulated curves have similar shapes (red curves are very close to each other)

$I_b$

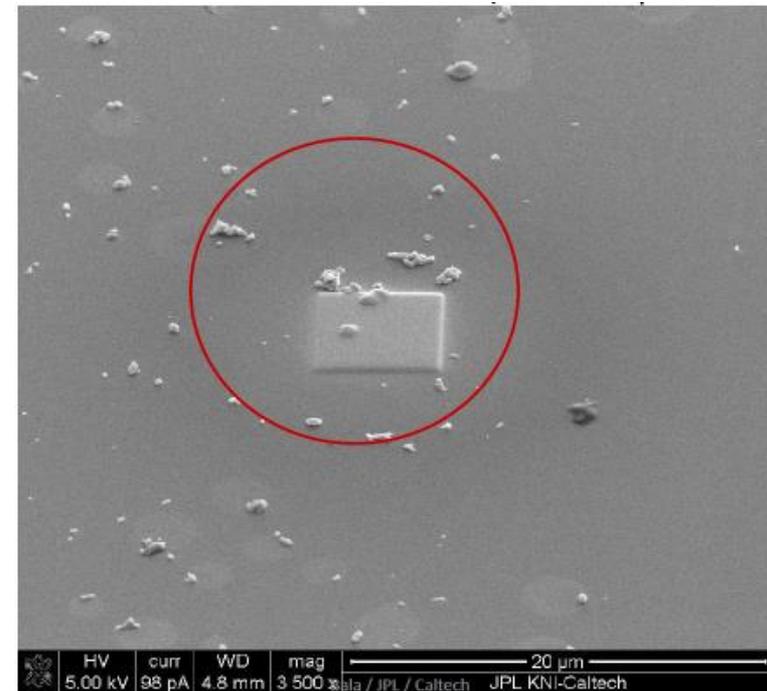
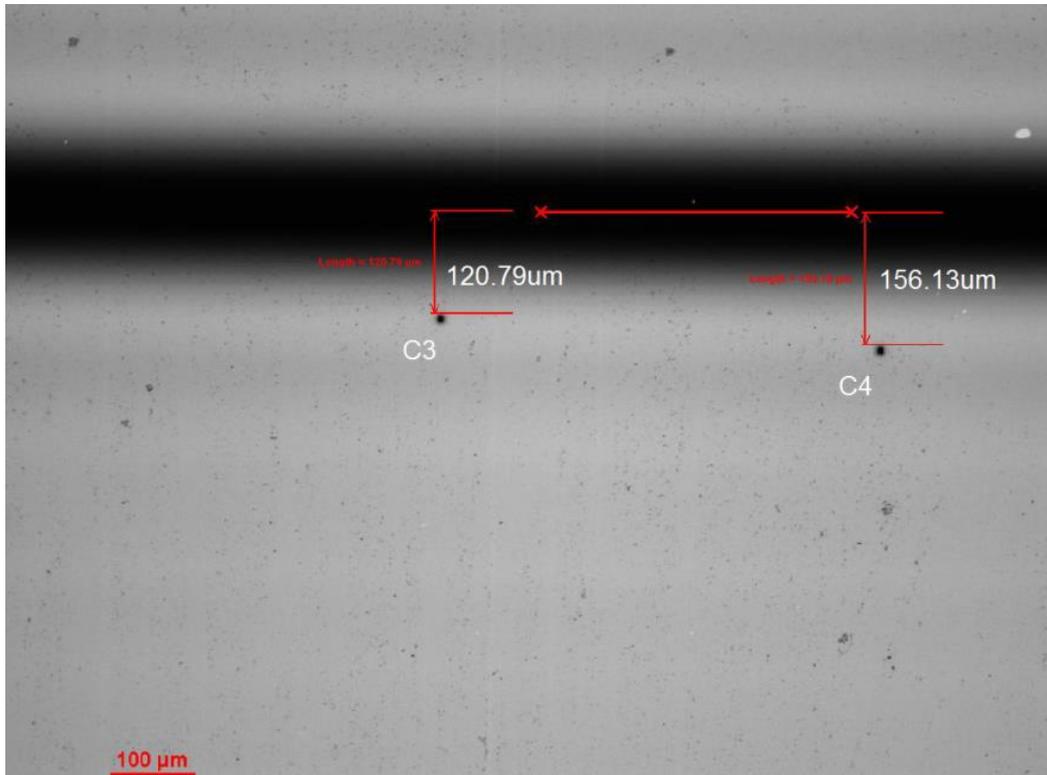


$I_s$



# Opaque Spot on Occulter: AFM/SEM Images

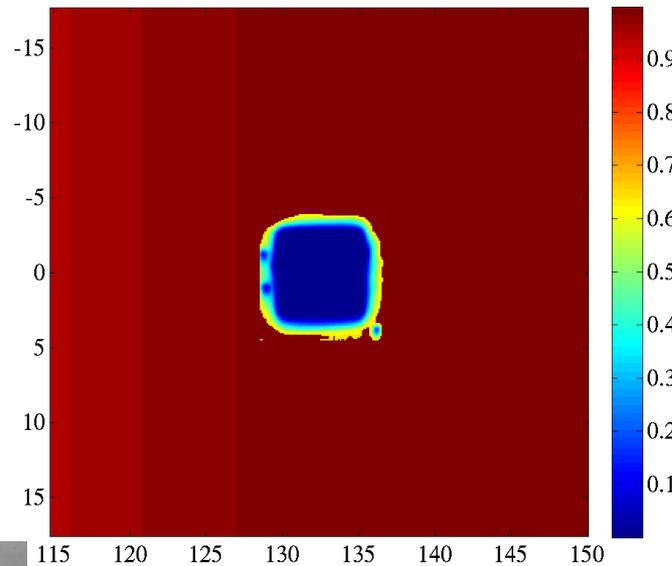
- Occulter is fabricated by vacuum deposition of varying thickness Nickel layer on a glass
- Added 6x6  $\mu\text{m}$  square shaped marks of Platinum (Pt) to represent dust particle or coating defect
- Left: Optical microscope image of two spots, C3 & C4
- Right: SEM (scanning-electron-microscope) image of C3-spot
- Rectangular shape caused by 52-deg tilted observation of a square mark
- Performance is evaluated one-spot at a time



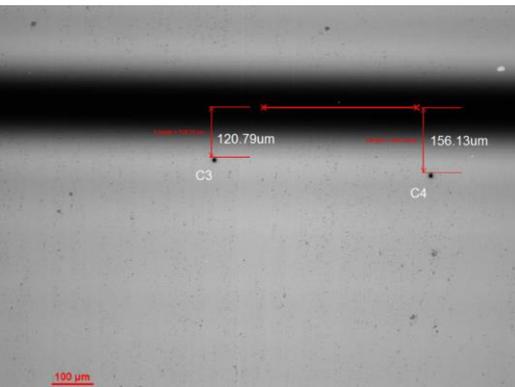
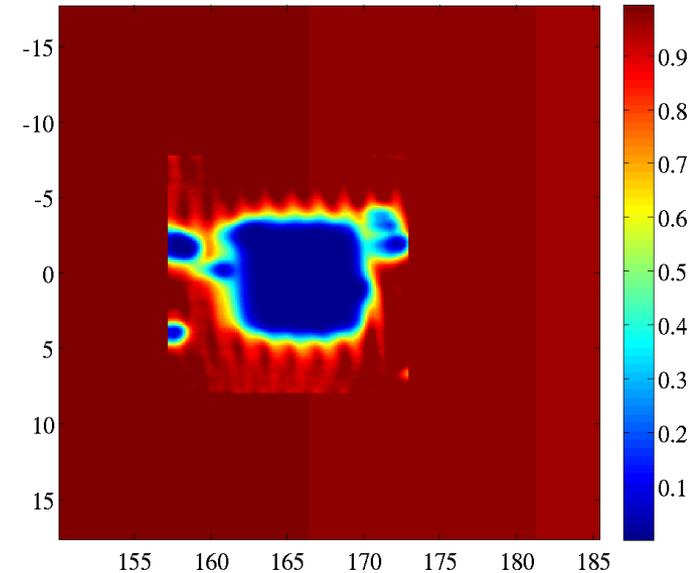
# Modeling of an Opaque Spot on Occulter

- Up-sampled occulter transmission to match with spot pixel size
- Replaced part of the occulter transmission with actual spot data
- Down-sampled the resultant occulter transmission map to the original occulter transmission sampling ( $\Delta x \sim 8.5\mu\text{m}$ )

**C3-spot:  $w = 6\mu\text{m}$ ,  $\Delta x = 0.0984\mu\text{m}$**



**C4-spot:  $w = 6\mu\text{m}$ ,  $\Delta x = 0.1228\mu\text{m}$**

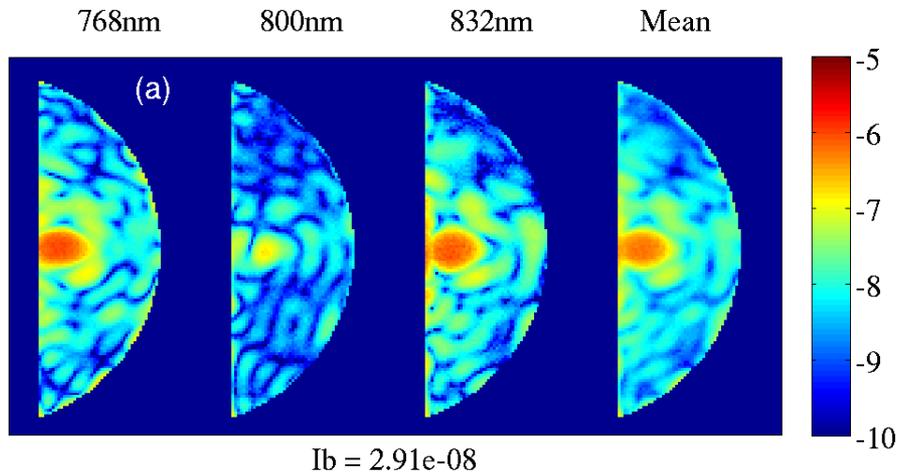


**Data are AFM (atomic-force microscope) images of two spots**

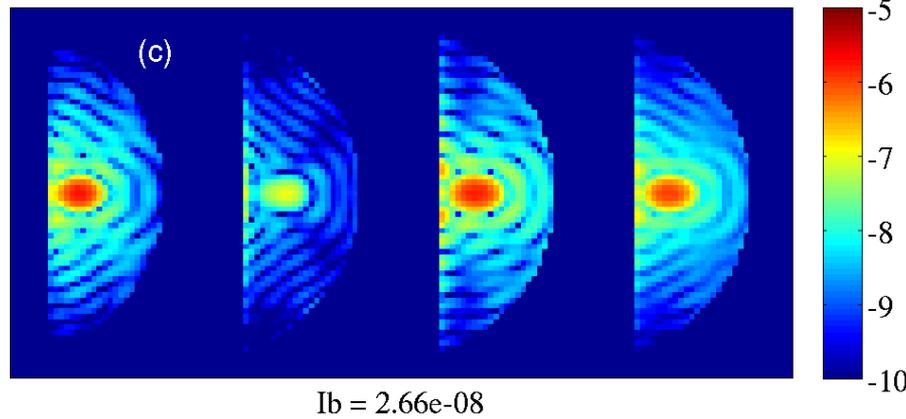
# Effects of Occulter C3-Spot

- Measurement and prediction are fairly close, especially the  $I_b$ -values

## Normalized Intensity Maps

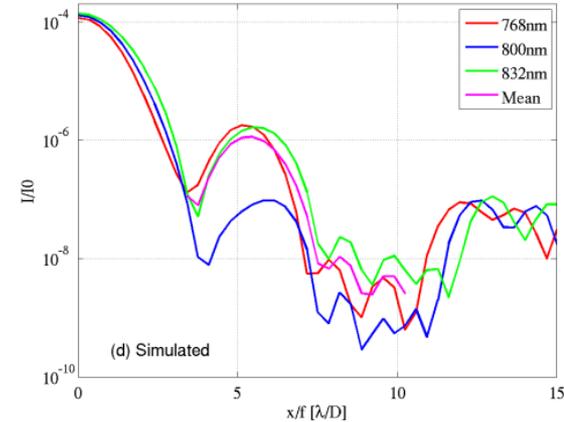
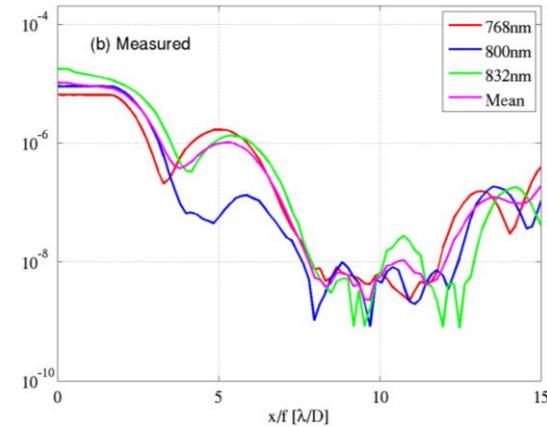


Measured



Predicted

## X-Profile at Y = 0

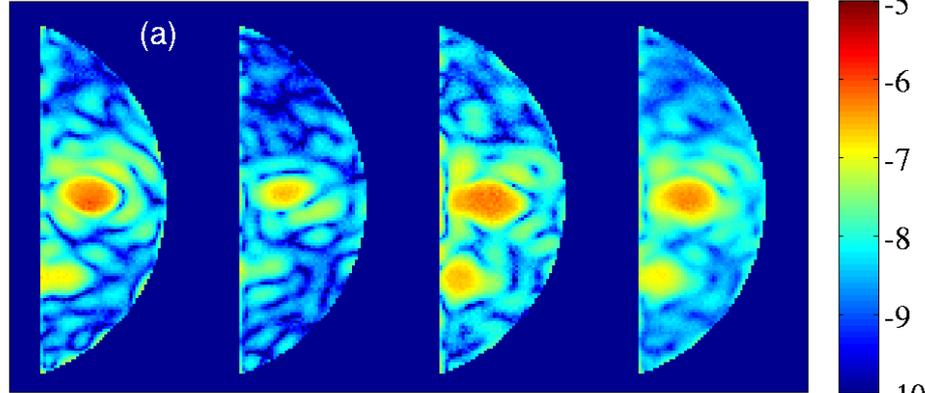


# Effects of Occulter C4-Spot

- Again, measurement and prediction are fairly close, especially the  $I_b$ -values
- Second spot near C4 is not intentional, and not modeled
- Residual exit-pupil phase-error is not included in simulations

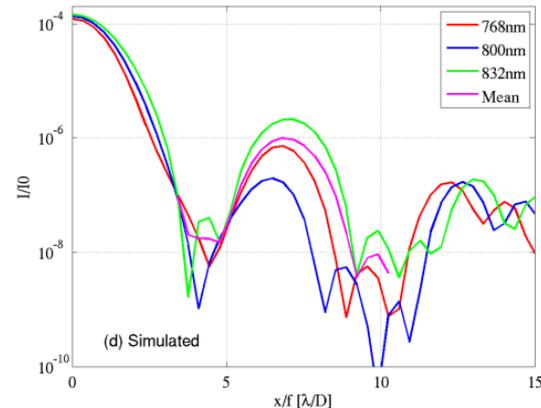
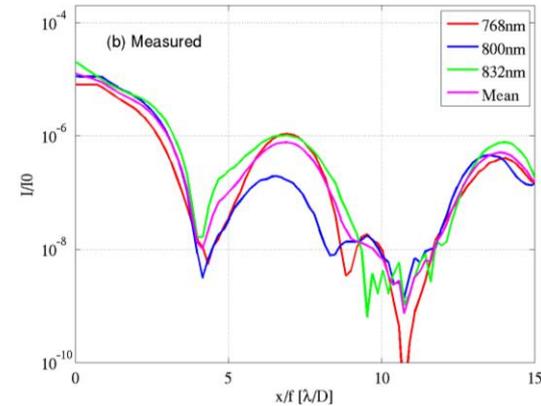
## Normalized Intensity Maps

768nm      800nm      832nm      Mean



$I_b = 2.5e-08$

## X-Profile at Y = 0



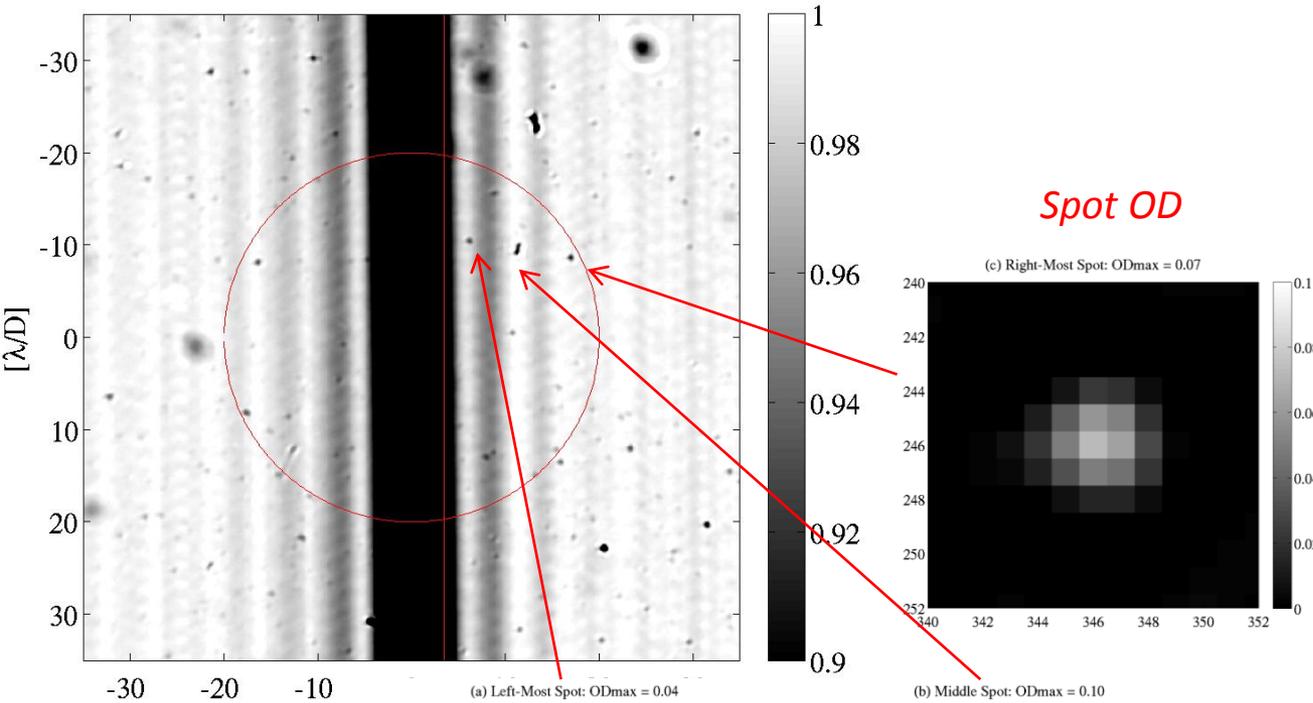
Measured

Predicted

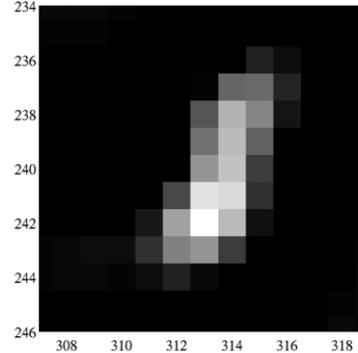
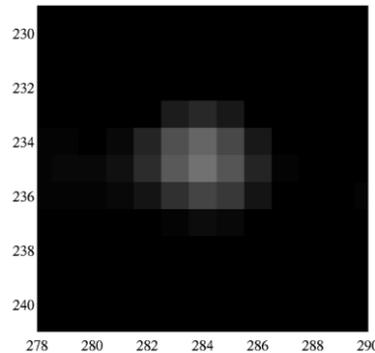
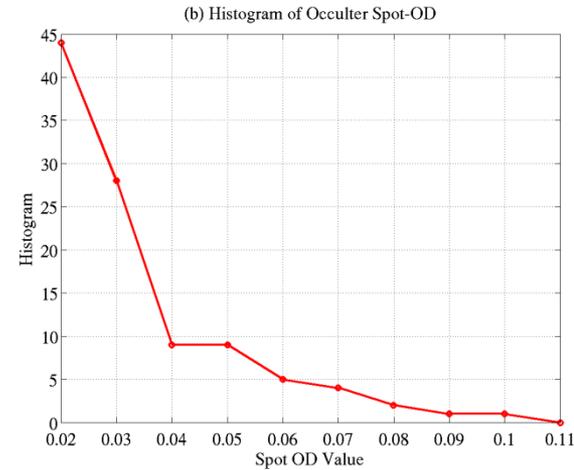
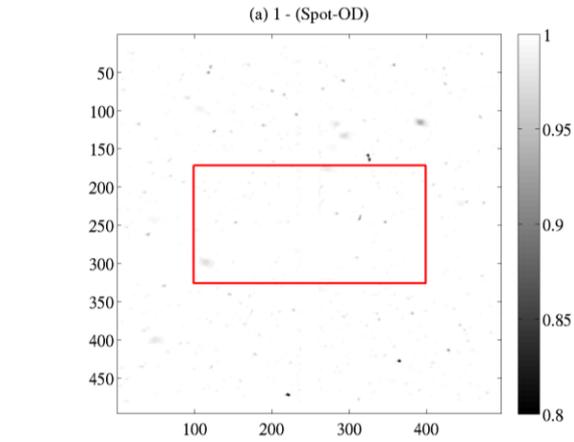
$I_b = 2.44e-08$

# Occulter Used for Dark-Hole Size

*Occulter Transmittance: Circle  $R = 20\lambda/D$*

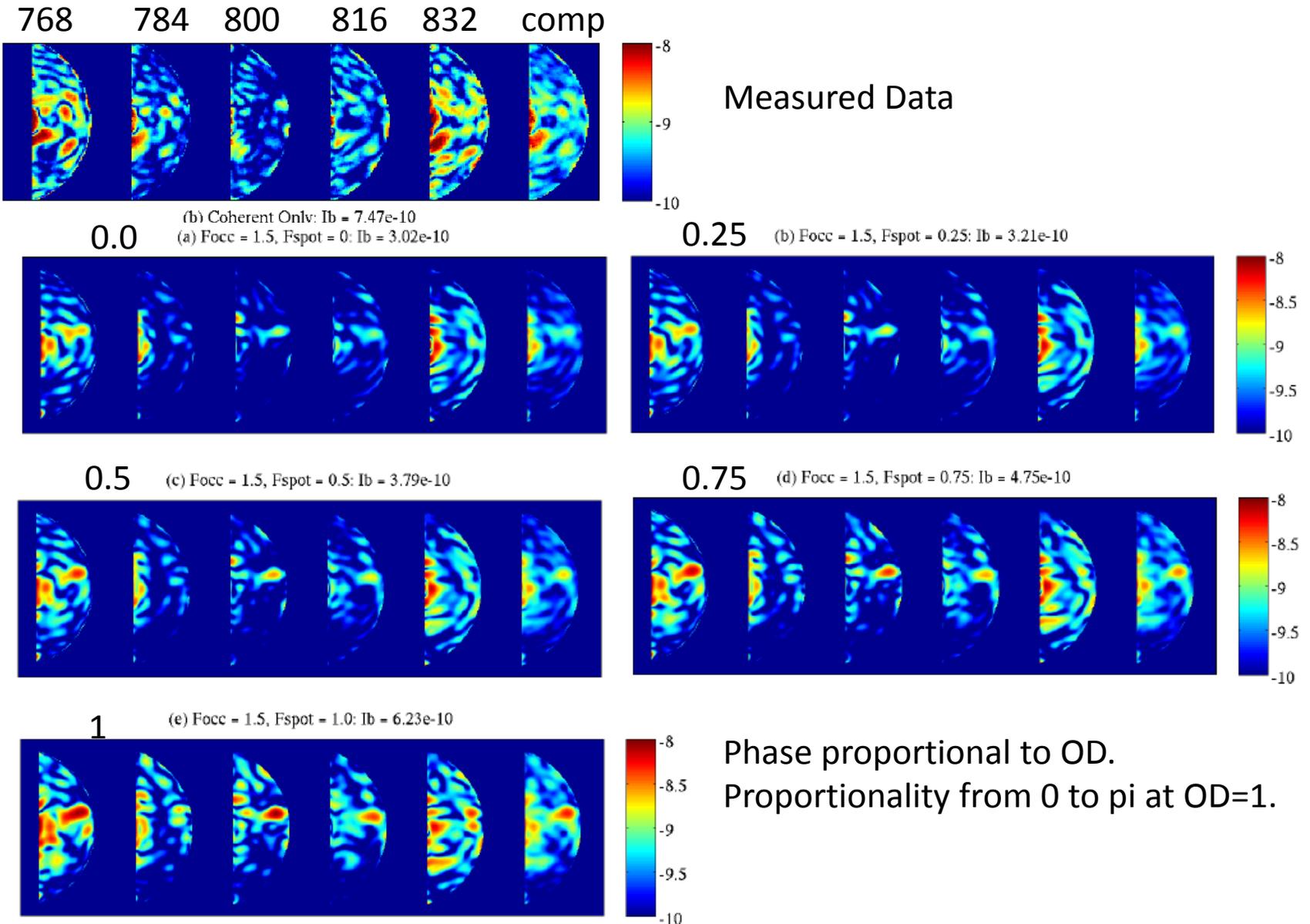


*Spot OD*



*Pix-size = 13/3  $\mu\text{m}$  = 4.33  $\mu\text{m}$*

# Trying to Match the Model to the Data by Adjusting Particle Phase



# Dark Hole after Wavefront Control

## Particles shifted, then wavefront controlled

- Video removed, too big

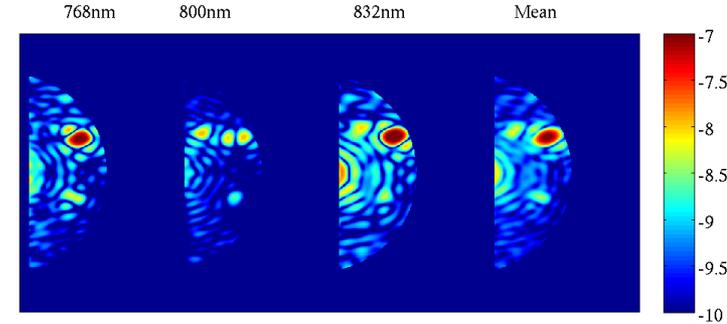
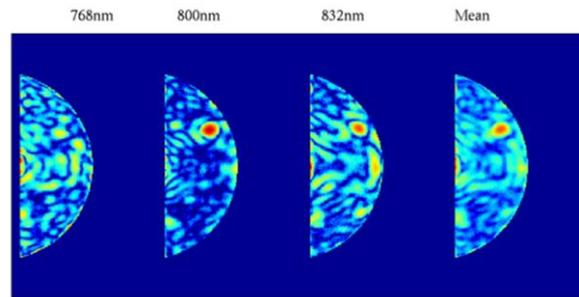
# Contrast versus Dark-Hole Size

$$\text{IntroduceD Occulter Spot Phase: } \Delta\varphi = OD_{spot} \times F_{spot} \times \pi, \quad F_{spot} = 1$$

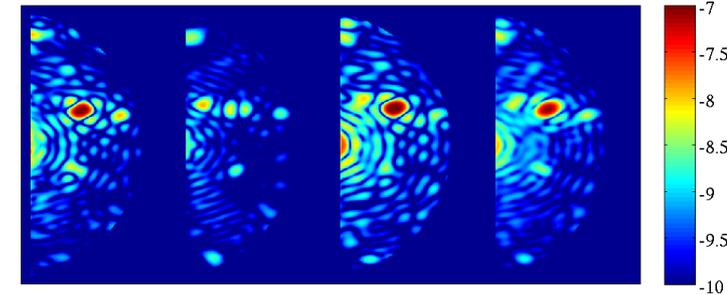
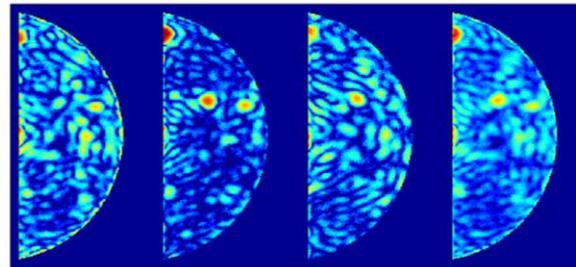
*Measured*

*Simulated*

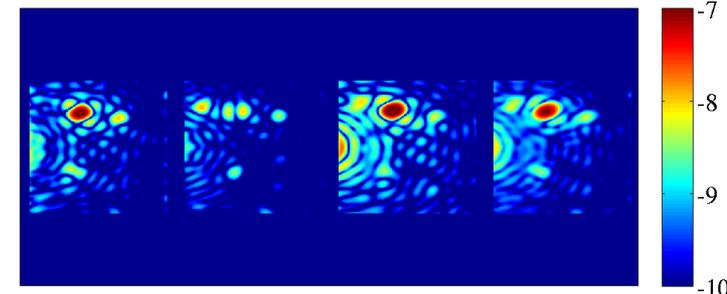
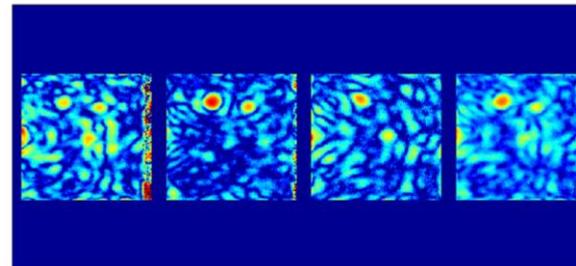
$$X_{min} = 3.5, R_{max} = 15 \lambda/D$$



$$X_{min} = 3.5, R_{max} = 20 \lambda/D$$

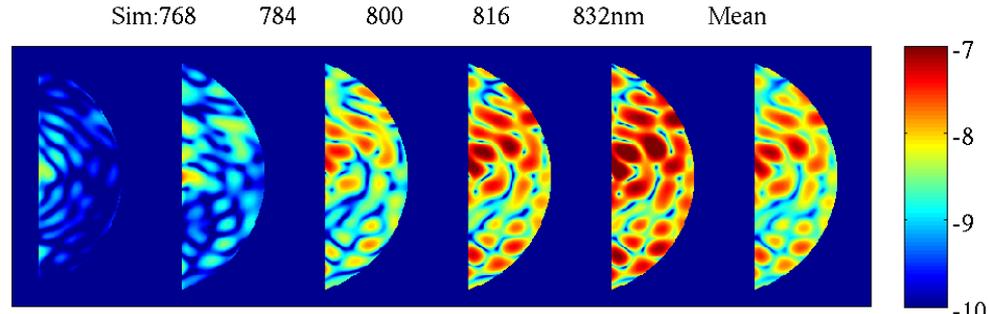
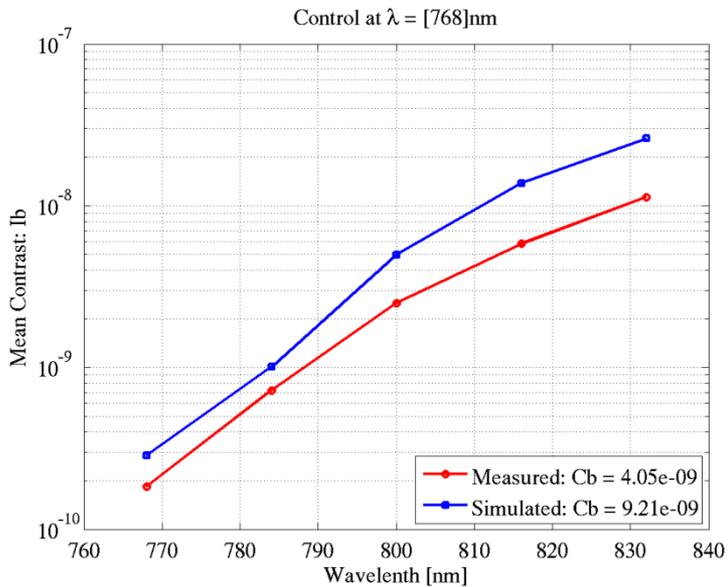
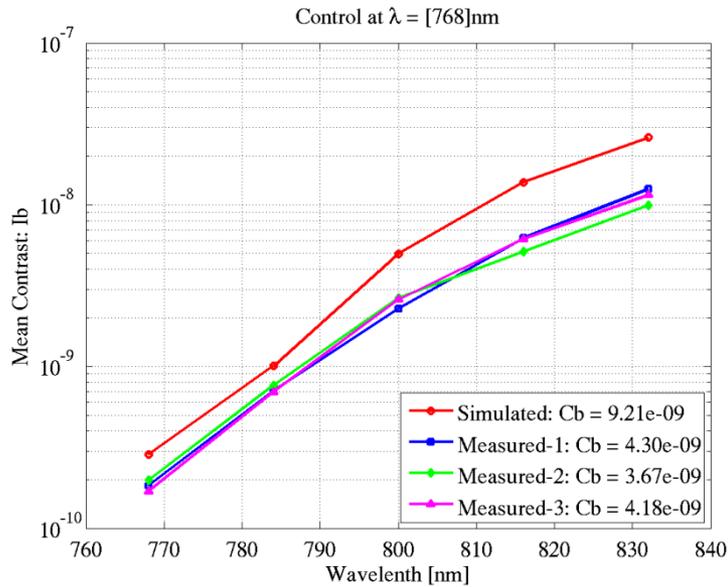


$$X = 3.5 - 24, Y = \pm 10 \lambda/D$$

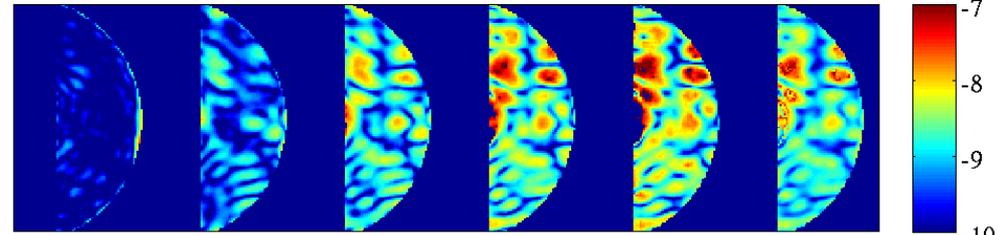


# Control Bandwidth: Control at $\lambda = 768\text{nm}$

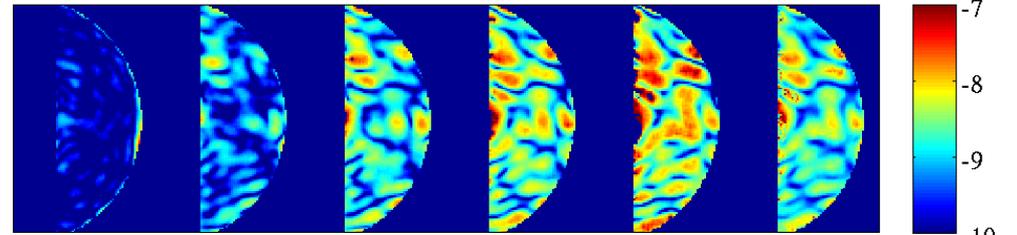
Top: Simulated. Rest: Measured.  $X_{min} = 3.5, R_{max} = 11 \lambda/D$



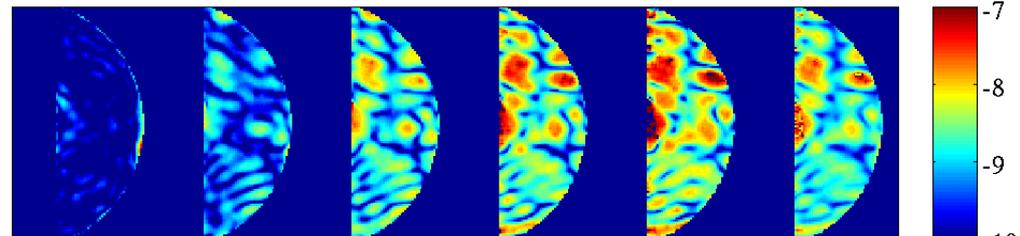
768: Cb = 2.85e-10 1.01e-09 4.98e-09 1.38e-08 2.60e-08 9.21e-09



Mea-1: Cb = 1.83e-10 7.06e-10 2.28e-09 6.22e-09 1.25e-08 4.30e-09

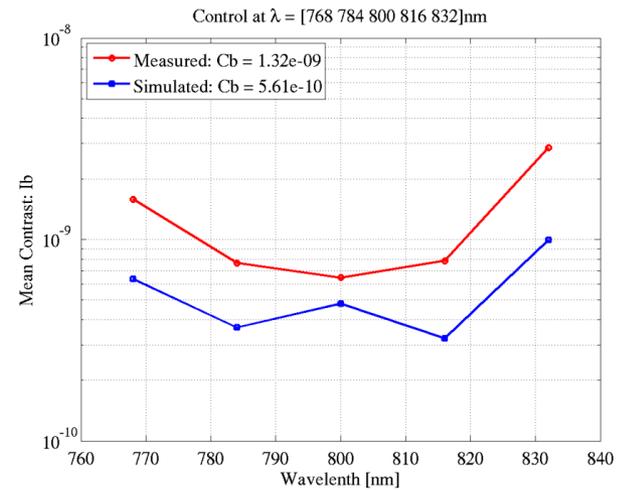
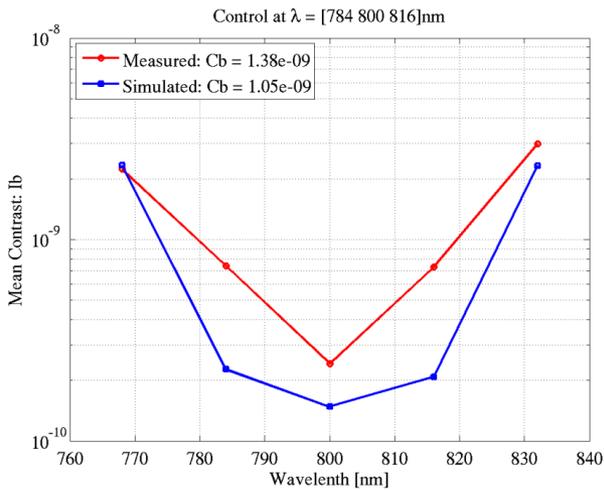
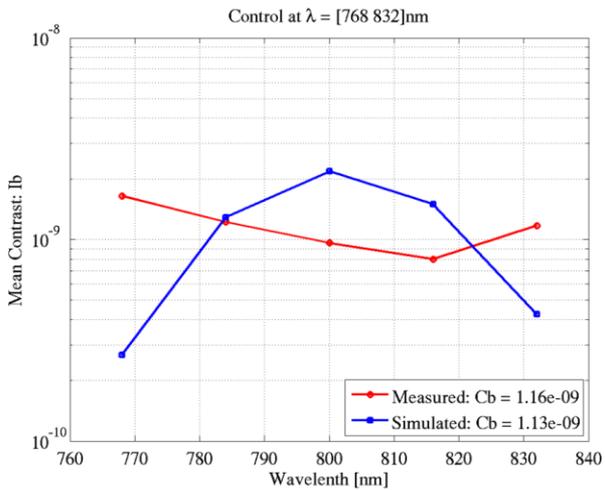
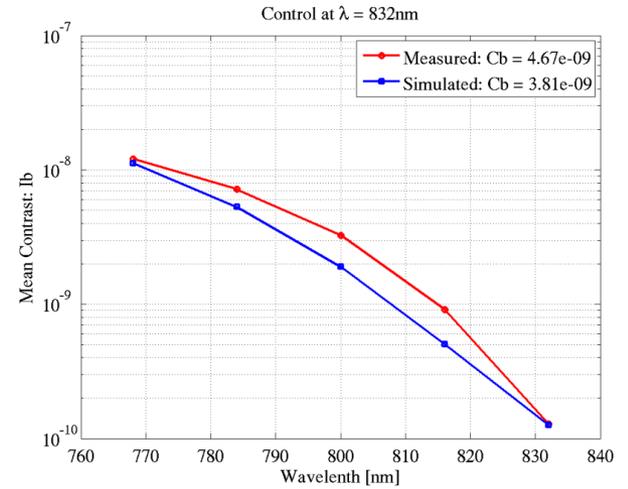
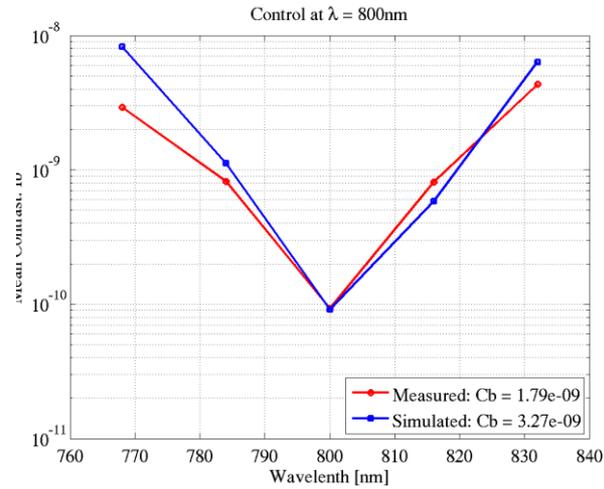
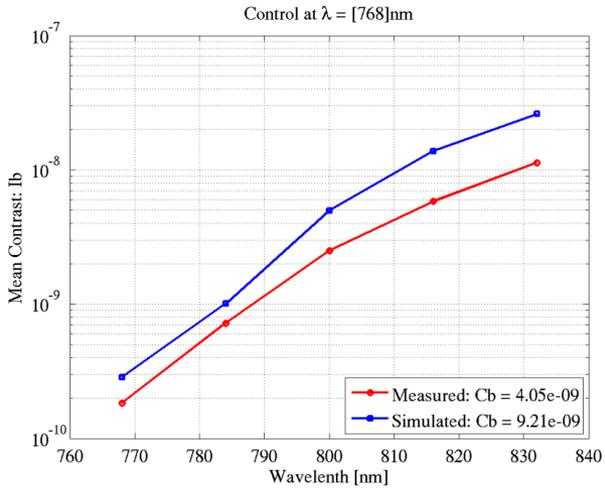


Mea-2: Cb = 1.97e-10 7.64e-10 2.65e-09 5.13e-09 9.89e-09 3.67e-09



Mea-3: Cb = 1.69e-10 6.96e-10 2.59e-09 6.12e-09 1.15e-08 4.18e-09

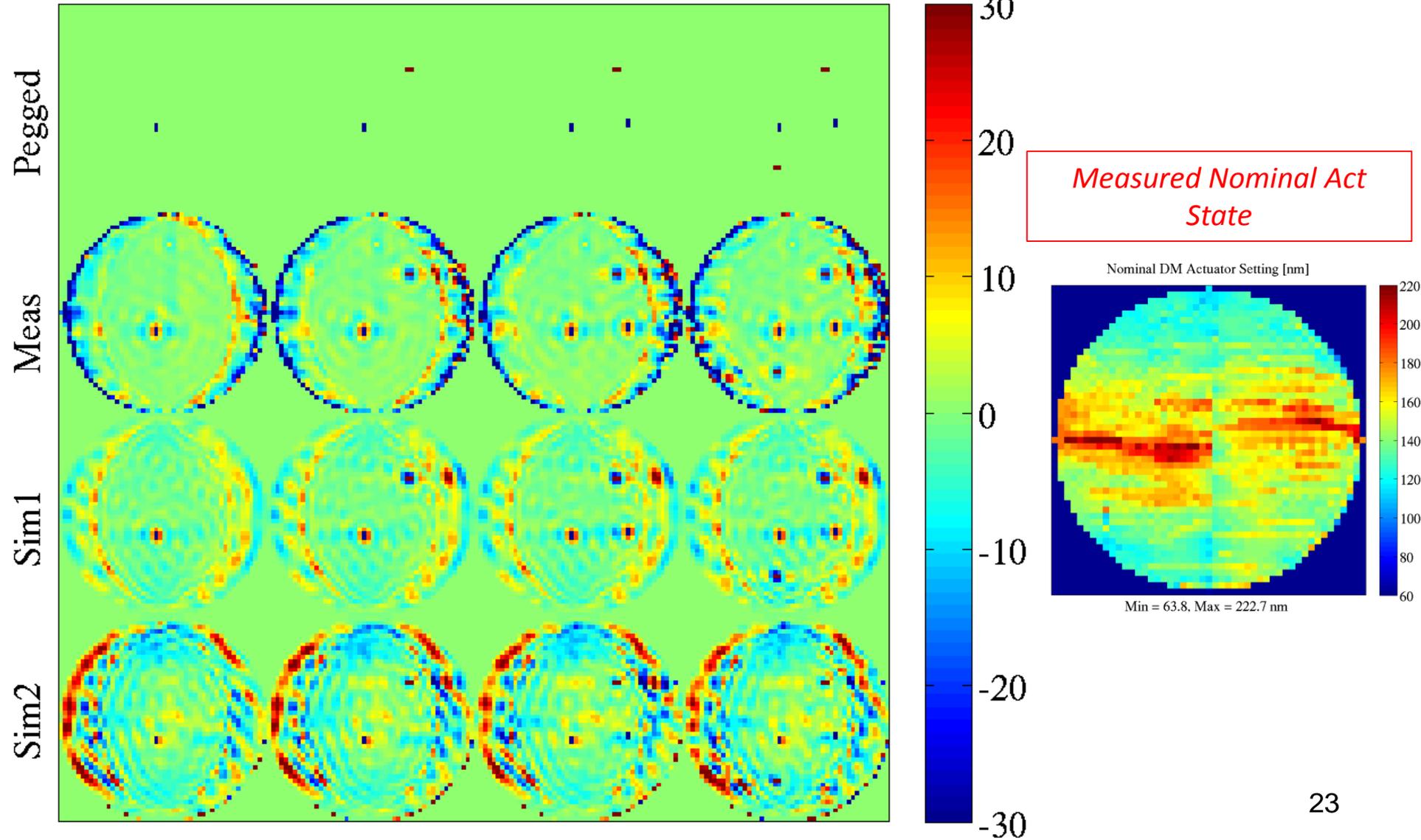
# Contrast versus Control Bandwidth



# Pegged Actuators: DM Actuator Commands

*Sim1: Starting with a Flat-DM. Sim2: Starting with "Meas" actuator state*

*Pegged actuators cause 125nm change in local WF*





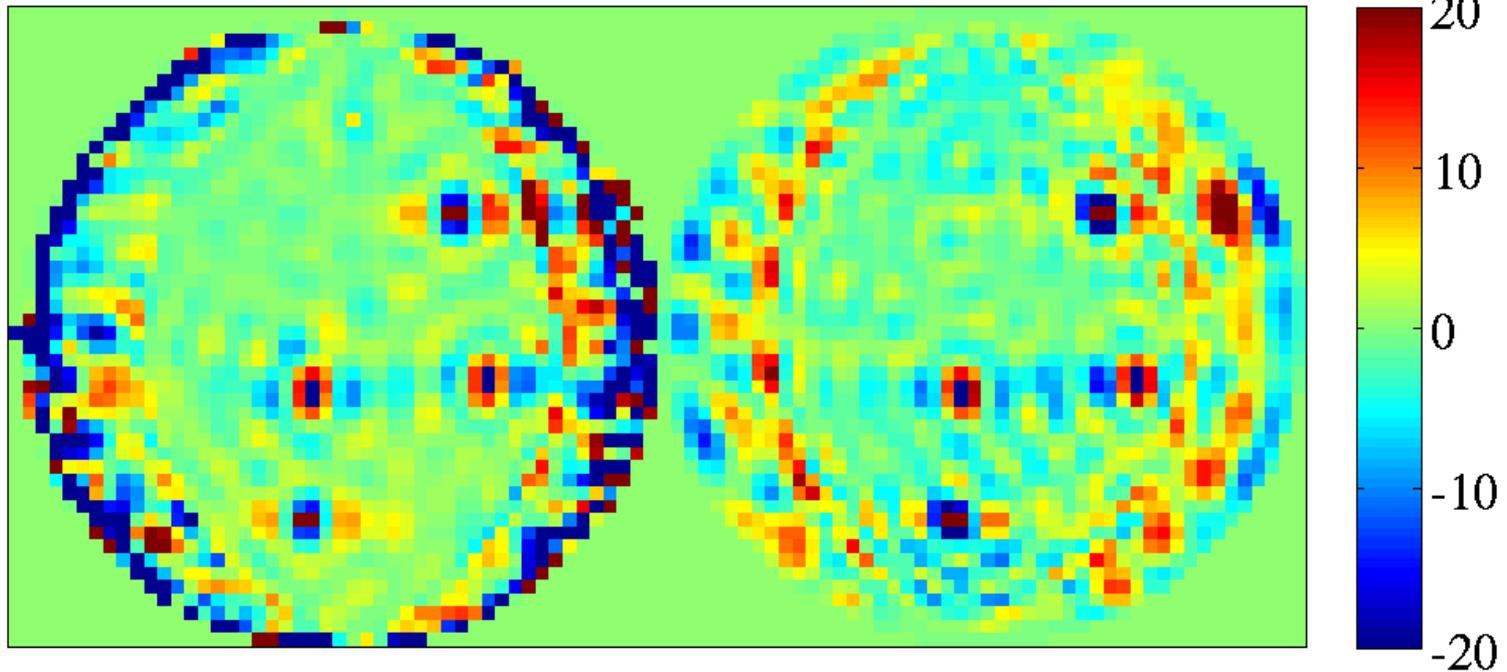
# Pegged Actuators: DM Actuator Commands

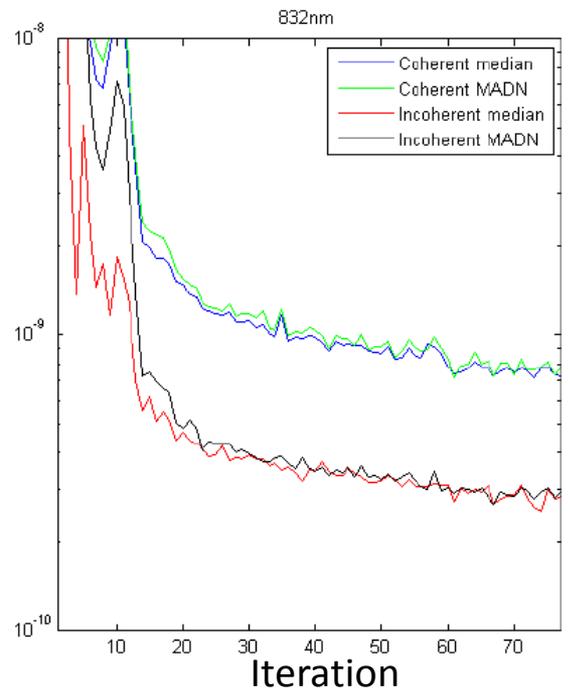
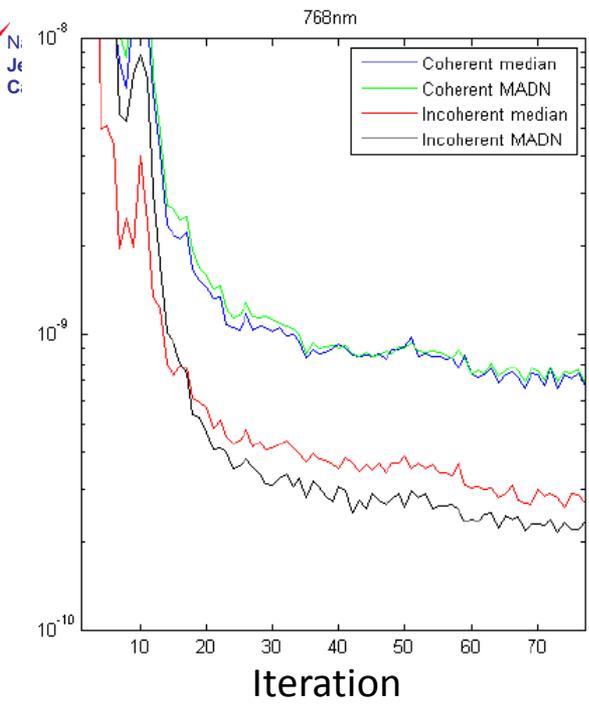
*Sim1: Starting with a Flat-DM. Sim2: Starting with "Meas" actuator state*

*Case of 4-Pairs Act Pegged*

Measured

Simulated-1



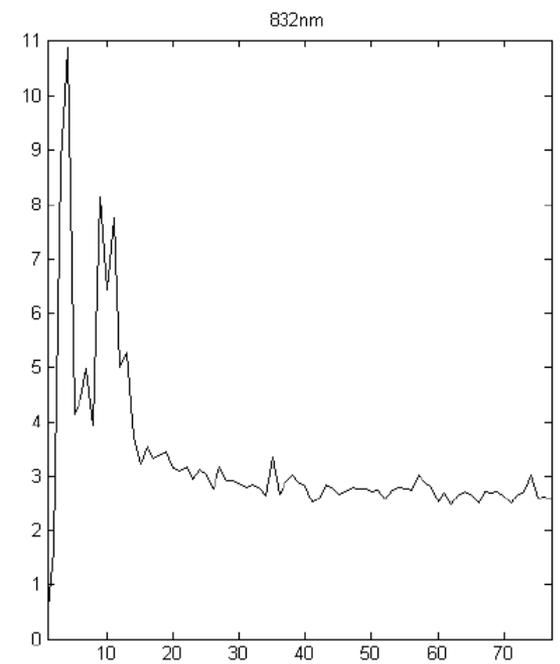
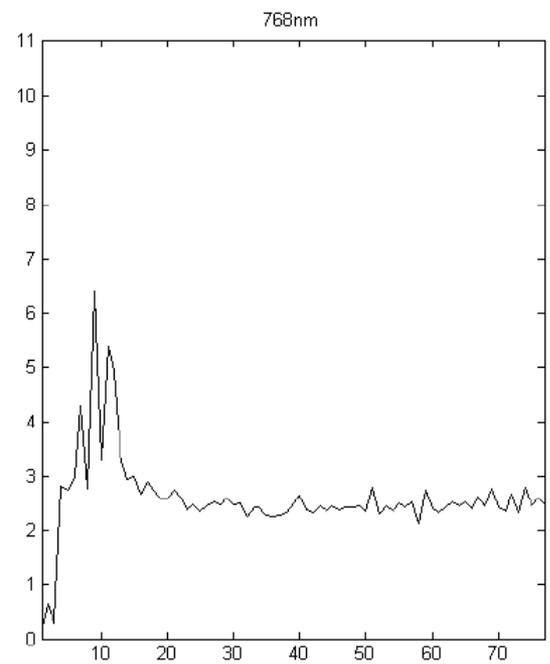


# Estimation Accuracy

Coherent and Incoherent Measurements

$$\text{Inc} = \text{Total} - \text{Coh}$$

Coh comes from wavefront estimation



Looks like Incoherent = 1/3 of Coherent.

We know this is not true: incoherent is much fainter.

Sidick, E., et al, “Studies of the effects of optical system errors on the HCIT contrast performance,” Proc. SPIE 8151, 815106 (ed. S. Shaklan) 2011.

Sidick, E., Shaklan, S., and Balasubramanian, K., “HCIT broadband contrast performance sensitivity studies,” Proc. SPIE 8520, 85200M (Ed. J. Dolne, T. Karr, V. Gamiz) 2012.

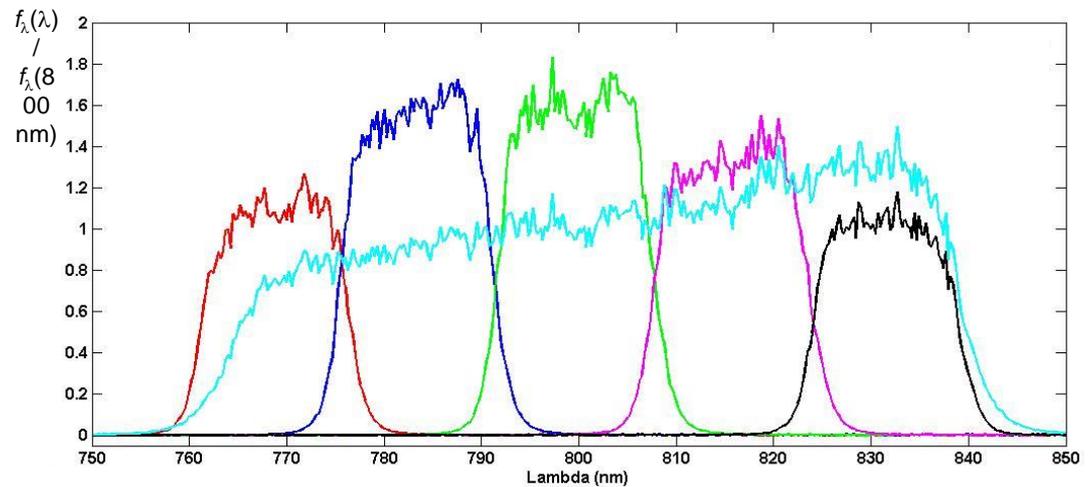
Sidick, E., et al, “HCIT contrast performance sensitivity studies: simulation vs. Experiment,” Proc. SPIE 8864, 88640Q (ed. S. Shaklan) 2013.

Sidick, E., et al, “High contrast coronagraph performance in the presence of focal plane mask defects,” Proc. SPIE 9143, 914336 (ed. J. Oschmann, M. Clampin, G. Fazio, H. MacEwen) 2014.

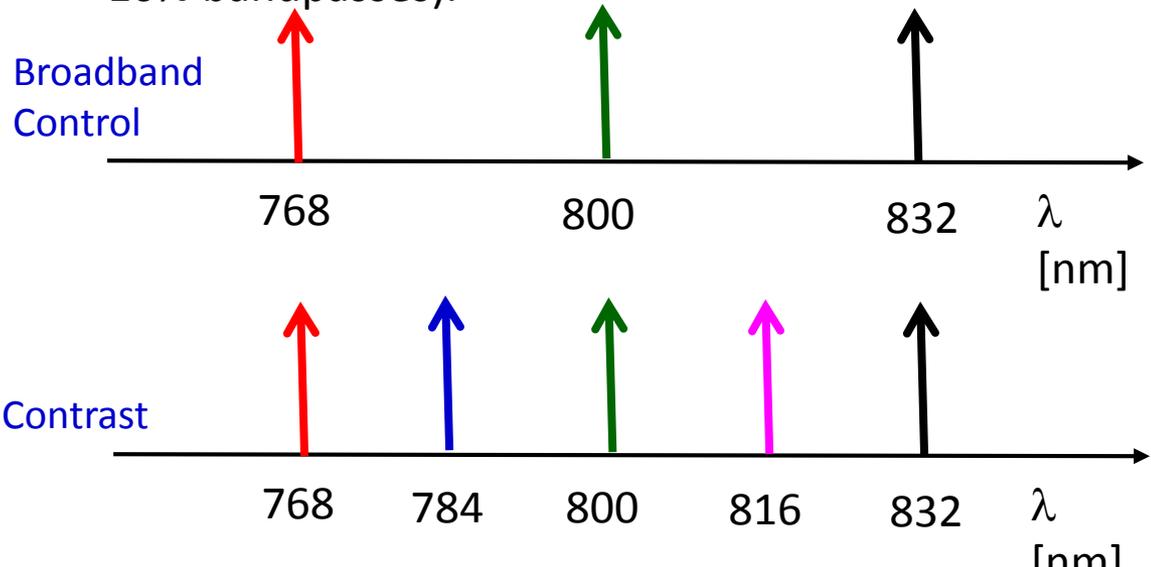
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# Broadband Control & Contrast: How They are Done

- A super-continuum source (shown on the right) is used for nulling
- WFC is carried out at 3 bands, each 2%, centered at 768, 800, 832nm
- In simulations, WFC is carried out at 3 monochromatic wavelengths: 768, 800, 832nm
- Broadband contrast is obtained by evaluating a single set of DM solutions at 5 monochromatic wavelengths, 768, 784, 800, 816, 832nm, and averaging the resulted intensity maps
- In some cases, will use more than 5 wavelengths to obtain a broadband intensity map



Measured net spectra of supercontinuum source, through each of six bandpass filters (Five 2% and one 10% bandpasses).



Broadband Contrast Evaluation